

**Notice of References Cited**

Application/Control No.

09/747,770

Applicant(s)/Patent Under  
Reexamination  
VANDERGEEST ET AL.

Examiner

BENJAMIN E. LANIER

Art Unit

2132

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,078,908	06-2000	Schmitz, Kim	705/50
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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